

AON6154

45V N-Channel MOSFET

General Description

- Trench Power MV MOSFET technology
- Low R_{DS(ON)}
- Low Gate Charge
- Optimized for fast-switching applications

Product Summary

 $\begin{array}{lll} V_{DS} & 45V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 100A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 1.5 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 4.5V) & < 2.1 m\Omega \end{array}$

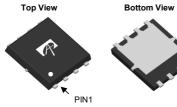
100% UIS Tested 100% Rg Tested

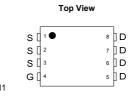


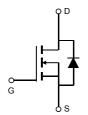
Applications

- Synchronous Rectification in DC/DC and AC/DC Converters
- Industrial and Motor Drive applications









Orderable Part Number Package Type		Form	Minimum Order Quantity		
AON6154	DFN 5x6	Tape & Reel	3000		

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V _{DS}	45	V	
Gate-Source Voltage		V_{GS}	±20	V	
Continuous Drain	T _C =25°C	ı	100		
Current ^G	T _C =100°C	'D	100	A	
Pulsed Drain Current C		I _{DM}	400		
Continuous Drain	T _A =25°C		49	А	
Current	T _A =70°C	IDSM	39		
Avalanche Current ^C		I _{AS}	45	A	
Avalanche energy	L=0.3mH	E _{AS}	304	mJ	
V _{DS} Spike	10µs	V _{SPIKE}	54	V	
	T _C =25°C	P _D	125	W	
Power Dissipation B	T _C =100°C	- D	50	VV	
	T _A =25°C	D	6.2	W	
Power Dissipation ^A	T _A =70°C	P _{DSM}	4.0	VV	
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C	

Thermal Characteristics						
Parameter		Symbol	Тур	Max	Units	
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\theta JA}$	15	20	°C/W	
Maximum Junction-to-Ambient AD	Steady-State	Т∙өЈА	40	50	°C/W	
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	0.8	1.0	°C/W	



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		45			V
I _{DSS}	I _{DSS} Zero Gate Voltage Drain Current	V _{DS} =45V, V _{GS} =0V				1	
iDSS	Zero Gate Voltage Drain Current		T _J =55°C			5	μA
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±20V				±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$		1.4	1.85	2.4	V
		V_{GS} =10V, I_D =20A			1.2	1.5	mΩ
$R_{DS(ON)}$	Static Drain-Source On-Resistance		T _J =125°C		1.85	2.3	11122
		V_{GS} =4.5V, I_D =20A			1.6	2.1	mΩ
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =20A			100		S
V_{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V			0.65	1	V
Is	Maximum Body-Diode Continuous Cur	rrent ^G				100	Α
DYNAMIC	PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =22.5V, f=1MHz			6575		pF
Coss	Output Capacitance				870		pF
C _{rss}	Reverse Transfer Capacitance				82		pF
R_g	Gate resistance	f=1MHz		0.5	1.1	1.7	Ω
SWITCHI	NG PARAMETERS	•					
$Q_g(10V)$	Total Gate Charge	V _{GS} =10V, V _{DS} =22.5V, I _D =20A			86	120	nC
Q _g (4.5V)	Total Gate Charge				38	54	nC
Q_{gs}	Gate Source Charge				19		nC
Q_{gd}	Gate Drain Charge				6		nC
t _{D(on)}	Turn-On DelayTime				17		ns
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =22.5V, R_L =1.125 Ω , R_{GEN} =3 Ω			5.5		ns
$t_{D(off)}$	Turn-Off DelayTime				56		ns
t_f	Turn-Off Fall Time				5		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, di/dt=400A/μs			22		ns
Q _{rr}	Body Diode Reverse Recovery Charge	I_F =20A, di/dt=400A/ μ	S		60		nC

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power

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the user's specific board design.

B. The power dissipation P_D is based on T_{J(MAX)}=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $T_{J(MAX)}$ =150° C. D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =150 $^{\circ}\,$ C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

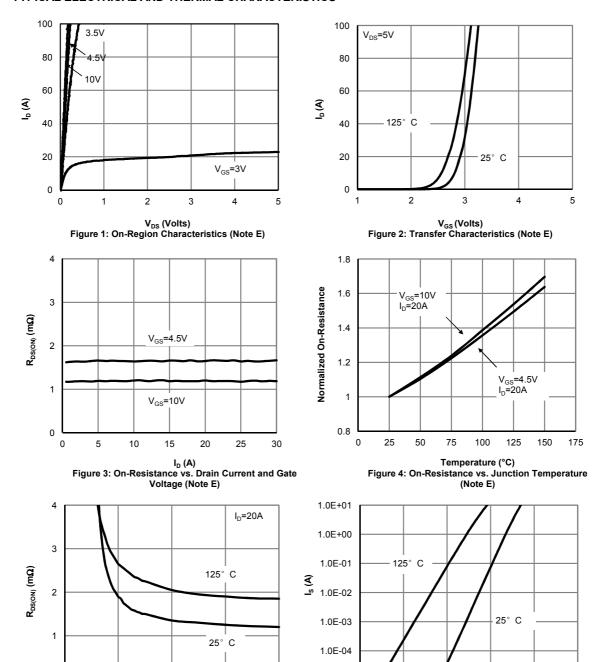
H. These tests are performed with the device mounted on 1 in FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C.



0

2

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



1.0E-05

0.0

0.2

0.4

V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)

0.6

0.8

1.0

8

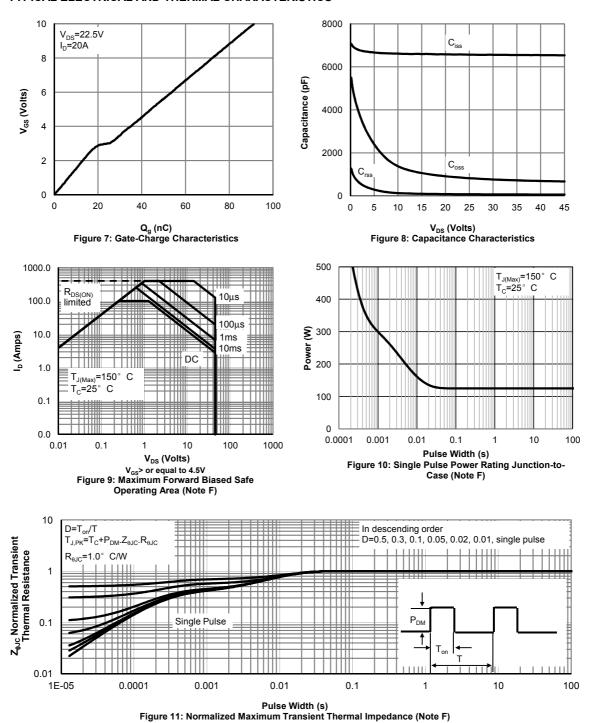
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V_{GS} (Volts)
Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

10

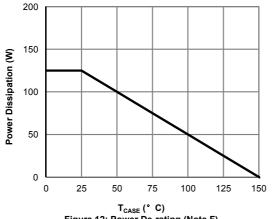


TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





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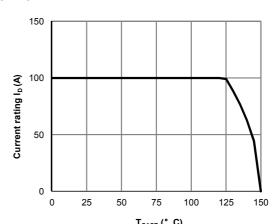
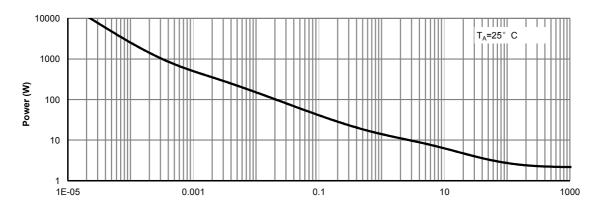
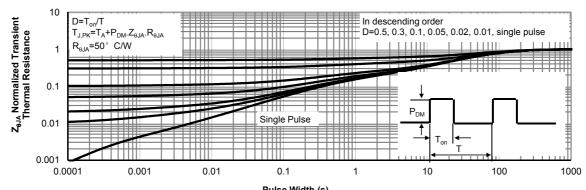


Figure 12: Power De-rating (Note F)

T_{CASE} (° C)
Figure 13: Current De-rating (Note F)



Pulse Width (s) Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)



Pulse Width (s)
Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

Figure A: Gate Charge Test Circuit & Waveforms

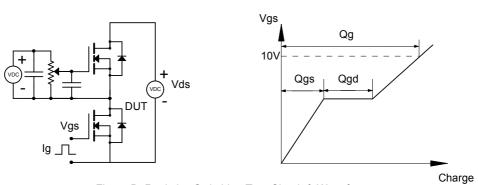


Figure B: Resistive Switching Test Circuit & Waveforms

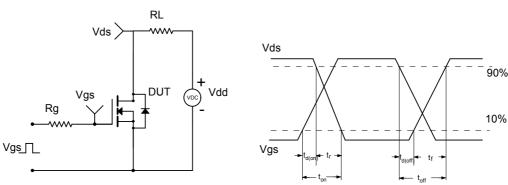


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

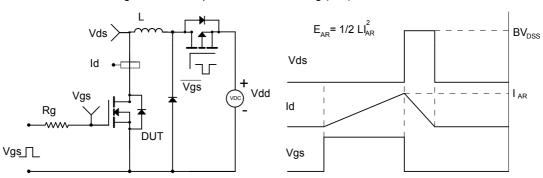


Figure D: Diode Recovery Test Circuit & Waveforms

